

# CA3094

## Programmable Power Switch/Amplifier for Control and General Purpose Applications

April 1994

#### Features

- CA3094T, E, M for Operation Up to 24V
- CA3094AT, E, M for Operation Up to 36V
- CA3094BT, M for Operation Up to 44V
- . Designed for Single or Dual Power Supply
- Programmable: Strobing, Gating, Squelching, AGC Capabilities
- Can Deliver 3W (Average) or 10W (Peak) to External Load (in Switching Mode)
- High Power, Single Ended Class A Amplifier will Deliver Power Output of 0.6W (1.6W Device Dissipation)
- Total Harmonic Distortion (THD) at 0.6W in Class A Operation 1.4% (Typ.)

## **Applications**

- Error Signal Detector: Temperature Control with Thermistor Sensor; Speed Control for Shunt Wound DC Motor
- Over Current, Over Voltage, Over Temperature Protectors
- Dual Tracking Power Supply with CA3085
- Wide Frequency Range Oscillator
- Analog Timer
- Level Detector
- Alarm Systems
- Voltage Follower
- Ramp Voltage Generator
- High Power Comparator
- · Ground Fault Interrupter (GFI) Circuits

## Ordering Information

PART NUMBER	TEMPERATURE RANGE	PACKAGE
CA3094T, AT, BT	-55°C to +125°C	8 Lead Metal Can
CA3094E, AE, BE	-55°C to +125°C	8 Lead Plastic DIP
CA3094M, AM, BA	-55°C to +125°C	8 Lead Plastic SOIC (N)

## Description

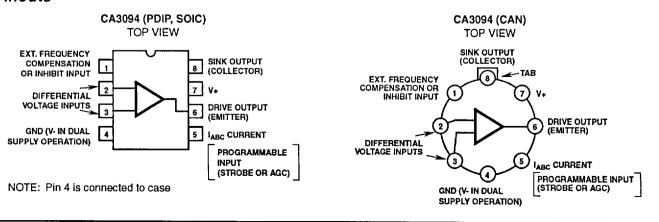
The CA3094 is a differential input power control switch/amplifier with auxiliary circuit features for ease of programmability. For example, an error or unbalance signal can be amplified by the CA3094 to provide an on-off signal or proportional control output signal up to 100mA. This signal is sufficient to directly drive high current thyristors, relays, DC loads, or power transistors. The CA3094 has the generic characteristics of the CA3080 operational amplifier directly coupled to an integral Darlington power transistor capable of sinking or driving currents up to 100mA.

The gain of the differential input stage is proportional to the amplifier bias current ( $I_{ABC}$ ), permitting programmable variation of the integrated circuit sensitivity with either digital and/or analog programming signals. For example, at an  $I_{ABC}$  of  $100\mu A$ , a 1mV change at the input will change the output from 0 to  $100\mu A$  (typical).

The CA3094 is intended for operation up to 24V and is especially useful for timing circuits, in automotive equipment, and in other applications where operation up to 24V is a primary design requirement (see Figures 28, 29 and 30 in Typical Applications text). The CA3094A and CA3094B are like the CA3094 but are intended for operation up to 36V and 44V, respectively (single or dual supply).

These types are available in 8 lead TO-99 Metal Cans ("T" suffix). Type CA3094 is also available in an 8 lead dual-in-line plastic DIP package ("E" suffix) and Small Outline Package ("M" suffix).

#### **Pinouts**



## Specifications CA3094, CA3094A, CA3094B

Absolute Maximum Ratings	Thermal Information		
CA3094       ±12V         CA3094A       ±18V         CA3094B       ±22V         Single Supply Voltage       24V         CA3094       24V         CA3094A       36V         CA3094B       44V         Differential Input Voltage (Term. 2 and 3) Note 1       5V	Thermal Resistance Plastic DIP Package Plastic SOIC Package Metal Can Junction Temperature Junction Temperature (Plastic Package) Lead Temperature (Soldering 10s) (SOIC - Lead Tips Only) Operating Temperature Range Storage Temperature Range	156°C/W	+150°C +300°C to +125°C

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

Electrical Specifications  $T_A = +25$ °C for Equipment Design. Single Supply V+ = 30V, Dual Supply V+ = 15V, V- = -15V,  $I_{ABC} = 100 \mu A$  Unless Otherwise Specified

PARAMETERS	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS
INPUT PARAMETERS				<u> </u>		<u>[</u>
Input Offset Voltage	V <sub>IO</sub>	T <sub>A</sub> = +25°C	-	0.4	5.0	mV
		$T_A = 0$ °C to +70°C	-		7.0	mV
Input Offset Voltage Change	IΔV <sub>IO</sub> I	Change in $V_{IO}$ between $I_{ABC} = 100\mu A$ and $I_{ABC} = 5\mu A$	-	1	8.0	mV
Input Offset Current	I <sub>IO</sub>	T <sub>A</sub> = +25°C	•	0.02	0.2	μА
		$T_A = 0$ °C to +70°C		-	0.3	μА
Input Bias Current	l <sub>i</sub>	T <sub>A</sub> = +25°C	. •	0.2	0.50	μА
		$T_A = 0$ °C to +70°C	•	-	0.70	μА
Device Dissipation	P <sub>D</sub>	I <sub>OUT</sub> = 0mA	8	10	12	mW
Common Mode Rejection Ratio	CMRR		70	110	•	dB
Common Mode Input Voltage Range	V <sub>ICR</sub>	V+ = 30V (High)	27	28.8	•	٧
	ļ	V- = 0V (Low)	1.0	0.5	-	V
		V+ = 15V	12	13.8		V
		V- = -15V	-14	-14.5	-	V
Unity Gain Bandwidth	f⊤	$I_C = 7.5$ mA, $V_{CE} = 15$ V, $I_{ABC} = 500$ µA	-	30	-	MHz
Open Loop Bandwidth at -3dB Point	BW <sub>OL</sub>	I <sub>C</sub> = 7.5mA, V <sub>CE</sub> = 15V, I <sub>ABC</sub> = 500μA	-	4	-	kHz
Total Harmonic Distortion	THD	P <sub>D</sub> = 220mW	-	0.4	-	%
(Class A Operation)		P <sub>D</sub> = 600mW	•	1.4	-	%
Amplifier Bias Voltage (Terminal 5 to Terminal 4)	V <sub>ABC</sub>		•	0.68		V
Input Offset Voltage Temperature Coefficient	ΔV <sub>IO</sub> /ΔΤ		•	4	-	μV/°C
Power Supply Rejection	ΔV <sub>IO</sub> /ΔV		-	15	150	μ٧/٧
1/F Noise Voltage	E <sub>N</sub>	f = 10Hz, I <sub>ABC</sub> = 50μA	-	18		nV/√Hz
1/F Noise Current	I <sub>N</sub>	f = 10Hz, I <sub>ABC</sub> = 50μA	-	1.8	•	p <b>A</b> /√Hz
Differential Input Resistance	R <sub>I</sub>	I <sub>ABC</sub> = 20μA	0.50	1.0		ΜΩ
Differential Input Capacitance	Cı	f = 1MHz, V+ = 30V	-	2.6		pF
OUTPUT PARAMETERS (Differential In	put Voltage = 1	V)		•	·	

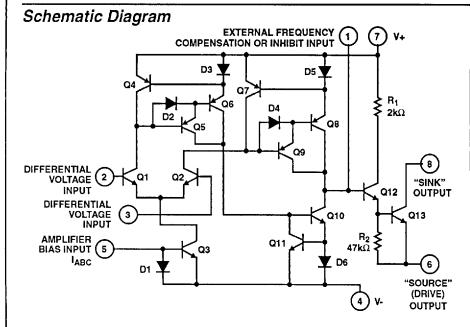
## Specifications CA3094, CA3094A, CA3094B

Electrical Specifications T<sub>A</sub> = +25°C for Equipment Design. Single Supply V+ = 30V, Dual Supply V+ = 15V, V- = -15V, I<sub>ABC</sub> = 100μA Unless Otherwise Specified (Continued)

PARAMI	ETERS	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Peak Output Voltage	With Q13 "ON"	V+OM	$V+ = 30V$ , $R_L = 2k\Omega$ to GND	26	27	-	٧
(Terminal 6)	With Q13 "OFF"	V-OM		-	0.01	0.05	٧
Peak Output Voltage	Positive	V+OM	V+ = 15 $V$ , $V$ - = -15 $V$ , $R$ <sub>L</sub> = 2 $k$ Ω to -15 $V$	11	12	•	٧
(Terminal 6)	Negative	V-OM		-	-14.99	-14.95	٧
Peak Output Voltage	With Q13 "OFF"	V+OM	$V + = 30V$ , $R_L = 2k\Omega$ to $30V$	29.95	29.99		٧
(Terminal 8)	With Q13 "ON"	V-OM		-	0.040	-	٧
Peak Output Voltage	Positive	V+OM	V+ = 15V, V- = -15V,	14.95	14.99	-	٧
(Terminal 8)	Negative	V-OM	$R_L = 2k\Omega$ to 15V	•	-14.96	-	٧
Collector-to-Emitter S (Terminal 8)	Saturation Voltage	V <sub>CE(SAT)</sub>	V+ = 30V, I <sub>C</sub> = 50mA, Terminal 6 Grounded	-	0.17	0.80	٧
Output Leakage Curr (Terminal 6 to Termin			V+ = 30V	-	2	10	μА
Composite Small Sign Ratio (Beta) (Q12 and		h <sub>FE</sub>	V+ = 30V, V <sub>CE</sub> = 5V, I <sub>C</sub> = 50mA	16,000	100,000	-	
Output Capacitance	Terminal 6	Co	f = 1MHz, All remaining Terminals Tied to Terminal 4	-	5.5	-	pF
	Terminal 8			-	17	•	pF
TRANSFER PARAM	ETERS						
Voltage Gain		А	A $V+=30V$ , $I_{ABC}=100\mu A$ , $\Delta V_{OUT}=20V$ , $R_L=2k\Omega$	20,000	100,000	-	V/V
				86	100	•	dB
Forward Transconductor	ctance to	9м		1650	2200	2750	μmhos
Slew Rate (Open Loop)	Positive Slope	SR	$I_{ABC} = 500\mu A$ , $R_L = 2k\Omega$	-	500	•	V/μs
	Negative Slope			-	50	•	V/μs
Unity Gain (Non-Inve	rting Compensated)		$I_{ABC} = 500\mu A, R_L = 2k\Omega$	-	0.70	-	V/μs

#### NOTE:

1. Exceeding this voltage rating will not damage the device unless the peak input signal current (1mA) is also exceeded.



		INPUTS	
OUTPUT MODE	OUTPUT TERM	INV	NON- INV
"Source"	6	2	3
"Sink"	8	3	2

## Typical Performance Curves

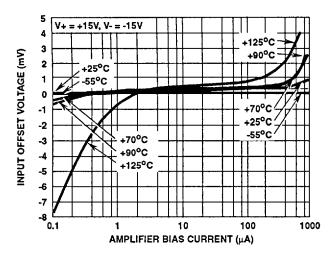


FIGURE 1. INPUT OFFSET VOLTAGE VS AMPLIFIER BIAS CURRENT (I<sub>ABC</sub>, TERMINAL 5)

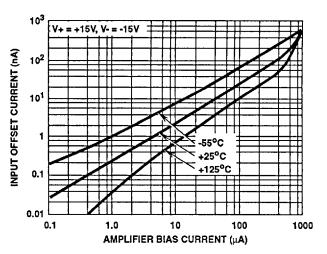


FIGURE 2. INPUT OFFSET CURRENT VS AMPLIFIER BIAS CURRENT (I<sub>ABC</sub>, TERMINAL 5)

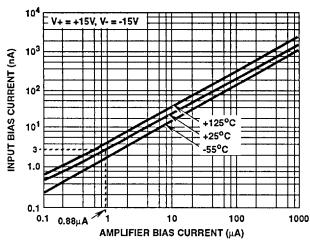


FIGURE 3. INPUT BIAS CURRENT vs AMPLIFIER BIAS CURRENT (I<sub>ABC</sub>, TERMINAL 5)

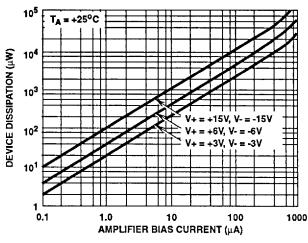


FIGURE 4. DEVICE DISSIPATION vs AMPLIFIER BIAS CURRENT (I<sub>ABC</sub>, TERMINAL 5)

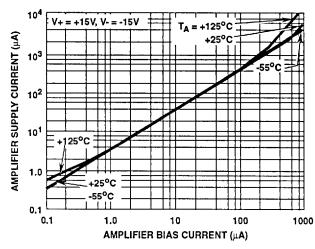


FIGURE 5. AMPLIFIER SUPPLY CURRENT vs AMPLIFIER BIAS CURRENT (I<sub>ABC</sub>, TERMINAL 5)

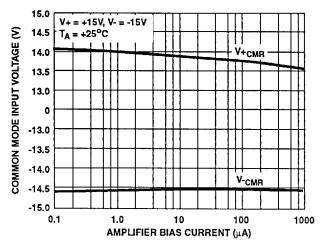


FIGURE 6. COMMON MODE INPUT VOLTAGE VS AMPLIFIER BIAS CURRENT (I<sub>ABC</sub>, TERMINAL 5)



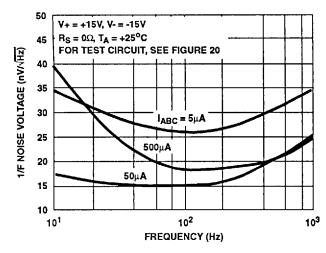


FIGURE 7. 1/F NOISE VOLTAGE vs FREQUENCY

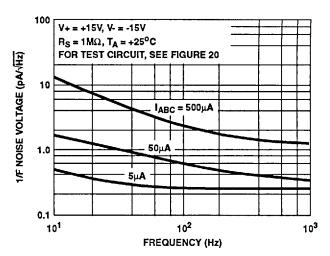


FIGURE 8. 1/F NOISE CURRENT vs FREQUENCY

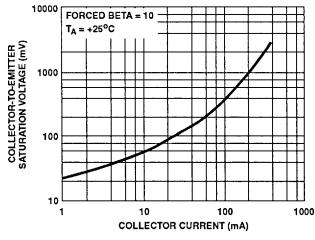


FIGURE 9. COLLECTOR EMITTER SATURATION VOLTAGE vs COLLECTOR CURRENT OF OUTPUT TRANSISTOR (Q13)

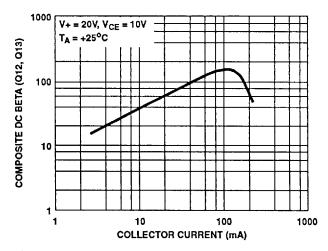


FIGURE 10. COMPOSITE DC BETA vs COLLECTOR CURRENT OF DARLINGTON CONNECTED OUTPUT TRAN-SISTORS (Q12, Q13)

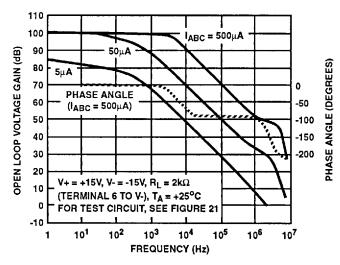


FIGURE 11. OPEN LOOP VOLTAGE GAIN vs FREQUENCY

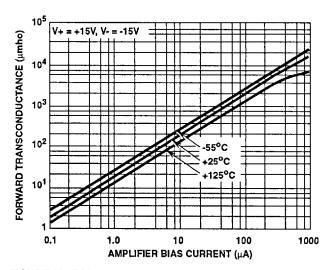


FIGURE 12. FORWARD TRANSCONDUCTANCE vs AMPLIFIER BIAS CURRENT

100

10

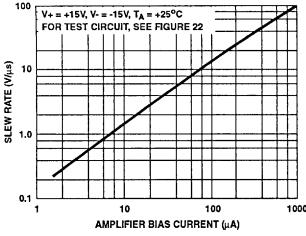
1.0

0.1

20

SLEW RATE (V/µs)

## Typical Performance Curves (Continued)



CLOSED LOOP VOLTAGE GAIN (dB)
FIGURE 14. SLEW RATE vs CLOSED LOOP VOLTAGE GAIN

60

80

100

40

V = +15V, V = -15V,  $I_{ABC} = 500\mu A$ ,  $T_A = +25^{\circ}C$ 

FOR TEST CIRCUIT, SEE FIGURE 23



FIGURE 13. SLEW RATE vs AMPLIFIER BIAS CURRENT

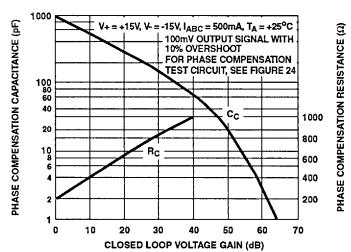


FIGURE 15. PHASE COMPENSATION CAPACITANCE AND RESISTANCE VS CLOSED LOOP VOLTAGE GAIN

## Operating Considerations

The "Sink" Output (Terminal 8) and the "Drive" Output (Terminal 6) of the CA3094 are not inherently current (or power) limited. Therefore, if a load is connected between Terminal 6 and Terminal 4 (V- or Ground), it is important to connect a current limiting resistor between Terminal 8 and Terminal 7 (V+) to protect transistor Q13 under shorted load conditions. Similarly, if a load is connected between Terminal 8 and Terminal 7 (V+), the current limiting resistor should be connected between Terminal 6 and Terminal 4 or ground. In circuit applications where the emitter of the output transistor is not connected to the most negative potential in the system, it is recommended that a  $100\Omega$  current limiting resistor be inserted between Terminal 7 and the V+ supply.

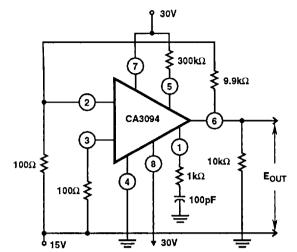
#### **Test Circuits**

#### 1/F Noise Measurement Circuit

When using the CA3094, A, or B audio amplifier circuits, it is frequently necessary to consider the noise performance of the device. Noise measurements are made in the circuit shown in Figure 20. This circuit is a 30dB, non-inverting amplifier with emitter follower output and phase compensation from Terminal 2 to ground. Source resistors (Rs) are set to 0 $\Omega$  or 1M $\Omega$  for E noise and I noise measurements, respectively. These measurements are made at frequencies of 10Hz, 100Hz and 1kHz with a 1Hz measurement bandwidth. Typical values for 1/f noise at 10Hz and 50 $\mu$ A I\_ABC are

$$E_N = 18nV/\sqrt{Hz}$$
 and  $I_N = 1.8pA/\sqrt{Hz}$ .

## **Test Circuits**



NOTES:  
1. Input Offset Voltage: 
$$V_{|O} = \frac{E_{OUT}}{100}$$
.

- 2. For Power Supply Rejection Test: (1) vary V+ by -2V; then (2) vary V- by +2V.
- 3. Equations:

(1) V+ Rejection = 
$$\frac{E_0OUT - E_1OUT}{200}$$

(2) V-Rejection = 
$$\frac{E_0OUT - E_2OUT}{200}$$

4. Power Supply Rejection: dB) = 
$$20\log \frac{1}{V_{REJECTION1}}$$

† Maximum Reading of Step 1 or Step 2

FIGURE 16. INPUT OFFSET VOLTAGE AND POWER SUPPLY REJECTION TEST CIRCUIT

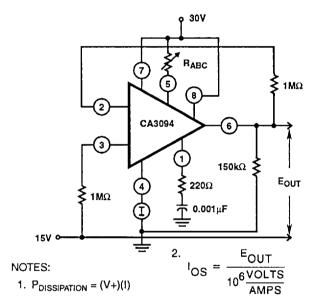
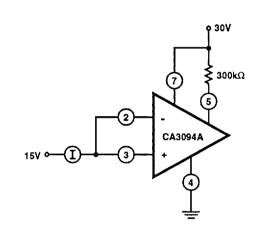
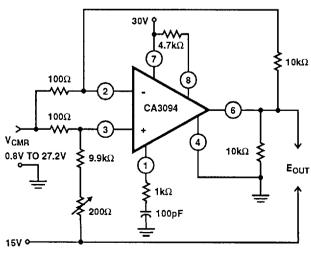


FIGURE 17. INPUT OFFSET CURRENT TEST CIRCUIT



NOTE: 
$$I_1 = \frac{1}{2}$$

FIGURE 18. INPUT BIAS CURRENT TEST CIRCUIT



NOTES:

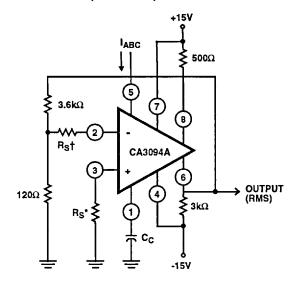
1. CMRR = 
$$\left| \frac{100 \times 26V}{E_{2OUT} - E_{1OUT}} \right|.$$

2. Input Voltage Range for CMRR = 1V to 27V.

3. CMRR (dB) = 
$$20log \left| \frac{100 \times 26V}{E_{2OUT} - E_{1OUT}} \right|$$
.

FIGURE 19. COMMON MODE RANGE AND REJECTION RATIO TEST CIRCUIT

## Test Circuits (Continued)

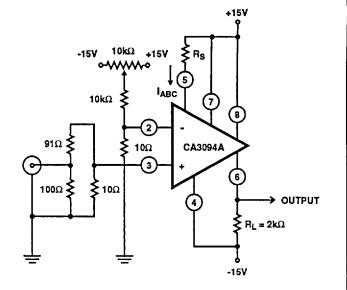


I <sub>ABC</sub> (μ <b>A</b> )	C <sub>COMP</sub> (pF)
5	0
50	50
500	500

NOTES:

- 1.  $R_S^{\dagger} = 1M\Omega$ (1/F Noise Current Test)
- 2.  $R_S = 0\Omega$  (1/F Noise Voltage Test)

FIGURE 20. 1/F NOISE TEST CIRCUIT



R <sub>S</sub> (Ω)	Ι <sub>ΑΒC</sub> (μΑ)
56K	500
560K	50
56M	5

FIGURE 21. OPEN LOOP GAIN vs FREQUENCY TEST CIRCUIT

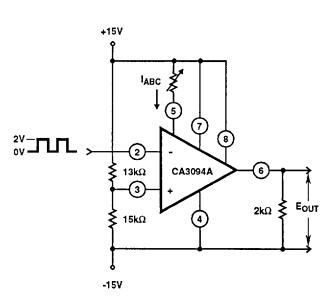


FIGURE 22. OPEN LOOP SLEW RATE vs  $I_{ABC}$  TEST CIRCUIT

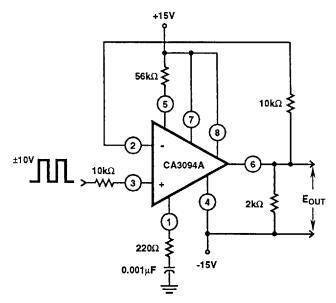
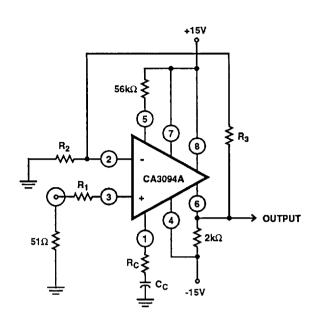


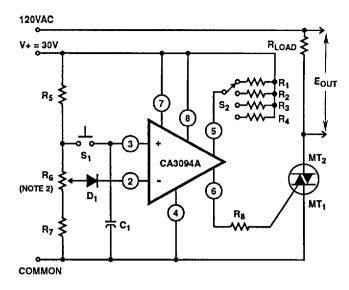
FIGURE 23. SLEW RATE vs NON-INVERTING UNITY GAIN TEST CIRCUIT

### Test Circuits (Continued)



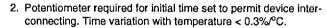
CLOSED LOOP GAIN (dB)	R <sub>1</sub> (kΩ)	$R_2$ (k $\Omega$ )	R <sub>3</sub> (kΩ)
0	10	∞	10
20	10	1	10
40	1	0.1	10

FIGURE 24. PHASE COMPENSATION TEST CIRCUIT



#### NOTES:

- 1.  $C_1 = 0.5 \mu F$ 
  - $D_1 = 1N914$
  - $R_1 = 0.51M\Omega = 3 \text{ min.}$  $R_2 = 5.1M\Omega = 30 \text{ min.}$
  - $H_3 = 22M\Omega = 2 \text{ hrs.}$
  - $H_3 = 22M\Omega = 2 \text{ nrs.}$  $R_4 = 44M\Omega = 4 \text{ hrs.}$
  - $R_5 = 1.5k\Omega$
  - $R_6 = 50k\Omega$
  - $R_7 = 5.1k\Omega$
  - $R_8 = 1.5k\Omega$



Time = 1 hr.

S2 Set to R4

FIGURE 25. PRESETTABLE ANALOG TIMER

## Typical Applications

For additional application information, refer to Application Note AN6048, "Some Applications of a Programmable Power/Switch Amplifier IC" and AN6077 "An IC Operational Transconductance Amplifier (OTA) with Power Capability".

#### **Design Considerations**

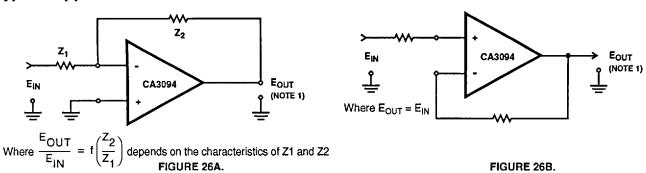
The selection of the optimum amplifier bias current ( $I_{ABC}$ ) depends on:

- The Desired Sensitivity The higher the I<sub>ABC</sub>, the higher the sensitivity, i.e., a greater drive current capability at the output for a specific voltage change at the input.
- Required Input Resistance The lower the I<sub>ABC</sub>, the higher the input resistance.

If the desired sensitivity and required input resistance are not known and are to be experimentally determined, or the anticipated equipment design is sufficiently flexible to tolerate a wide range of these parameters, it is recommended that the equipment designer begin his calculations with an  $I_{ABC}$  of  $100\mu A$ , since the CA3094 is characterized at this value of amplifier bias current.

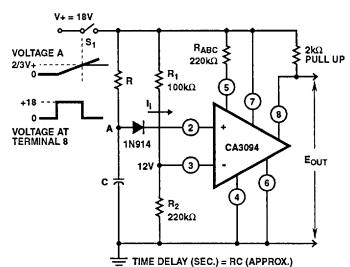
The CA3094 is extremely versatile and can be used in a wide variety of applications.

## Typical Applications



NOTE: 1. In single-ended output operation, the CA3094 may require a pull up or pull down resistor

#### FIGURE 26. APPLICATION OF THE CA3094: (a) AS AN INVERTING OP AMP AND (b) IN A NON-INVERTING MODE, AS A FOLLOWER



Problem: To calculate the maximum value of R required to switch a 100mA output current comparator

Given: 
$$I_{ABC} = 5\mu A$$
,  $R_{ABC} = 3.6M\Omega \approx \frac{18V}{5\mu A}$ 

 $I_1 = 500$ nA at  $I_{ABC} = 100\mu$ A (from Figure 3)

 $I_I$  = 5 $\mu$ A can be determined by drawing a line on Figure 3 through  $I_{ABC}$  = 100 $\mu$ A and  $I_B$  = 500nA parallel to the typical  $T_A$  = +25°C curve.

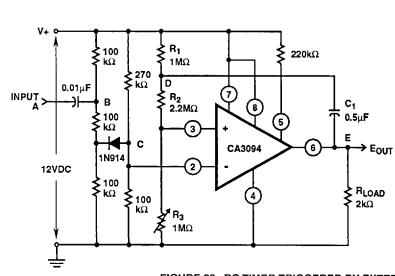
Then:  $I_1 = 33$ nA at  $I_{ABC} = 5\mu$ A

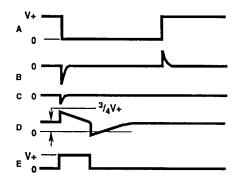
$$R_{MAX} = \frac{18V - 12V}{33nA} = 180M\Omega \text{ at } T_A = +25 \text{ °C}$$

$$R_{MAX} = 180M\Omega \times 2/3\dagger = 120M\Omega \text{ at } T_A = -55^{\circ}\text{C}$$

† Ratio of  $I_i$  at  $T_A = +25^{\circ}$ C to  $I_I$  at  $T_A = -55^{\circ}$ C for any given value of  $I_{ABC}$ 

FIGURE 27. RC TIMER



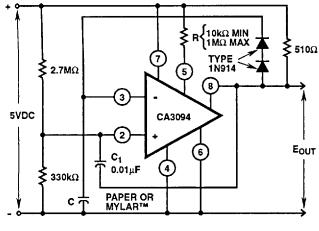


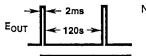
On a negative going transient at input (A), a negative pulse at C will turn "on" the CA3094, and the output (E) will go from a low to a high level.

At the end of the time constant determined by C1, R1, R2, R3, the CA3094 will return to the "off" state and the output will be pulled low by  $R_{LOAD}$ . This condition will be independent of the interval when input (A) returns to a high level.

FIGURE 28. RC TIMER TRIGGERED BY EXTERNAL NEGATIVE PULSE

## Typical Applications (Continued)





LINE

NOTES:

- 1.  $R = 1M\Omega$ ,  $C = 1\mu F$
- 2. Time Constant: t ≈ RC x 120
- 3. Pulse Width:  $\omega \approx K(C_1/C)$

FIGURE 29. FREE RUNNING PULSE GENERATOR

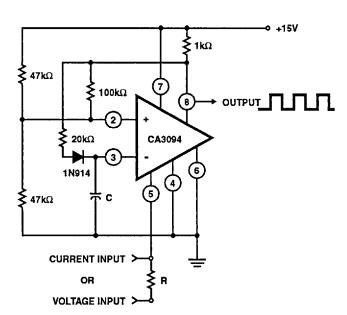


FIGURE 30. CURRENT OR VOLTAGE CONTROLLED OSCILLATOR

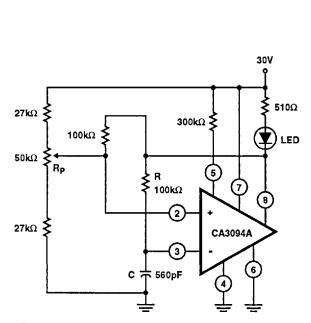
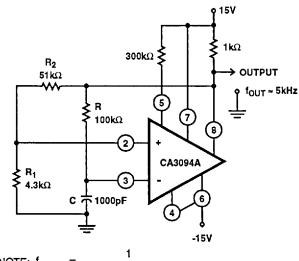


FIGURE 31. SINGLE SUPPLY ASTABLE MULTIVIBRATOR

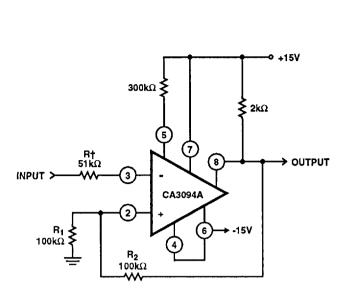


NOTE: 
$$f_{OUT} = \frac{1}{2RC \ln \left(\frac{2R_1}{R_2} + 1\right)}$$

If: 
$$R_2 = 3.08R_1$$
,  $f_{OUT} = \frac{1}{RC}$ 

FIGURE 32. DUAL SUPPLY ASTABLE MULTIVIBRATOR

## Typical Applications (Continued)



NOTES:  
1. Upper Threshold = 
$$[V+]$$
 
$$\left[\frac{R_B}{\left(\frac{R_1R_A}{R_1+R_A}\right)+R_B}\right]$$

NOTES:  
1. R† = 
$$\frac{R_1R_2}{R_1 + R_2}$$
  
2. ±Threshold = [±Supply]  $\left[\frac{R_1}{R_1 + R_2}\right]$ 

2. Lower Threshold = [V+] 
$$\frac{\frac{R_1 R_B}{R_1 + R_B}}{\left(\frac{R_1 R_B}{R_1 + R_B}\right) + R_A}$$

FIGURE 33A. DUAL SUPPLY

FIGURE 33B. SINGLE SUPPLY

FIGURE 33. COMPARATORS (THRESHOLD DETECTORS) DUAL AND SINGLE SUPPLY TYPES

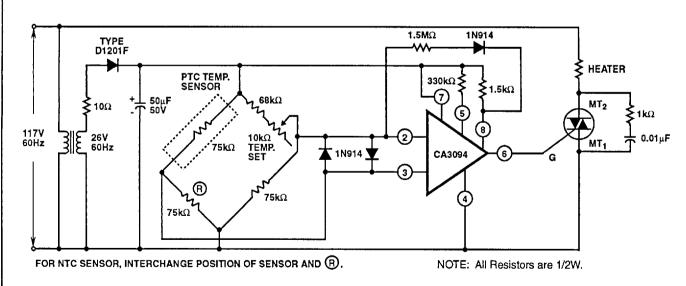
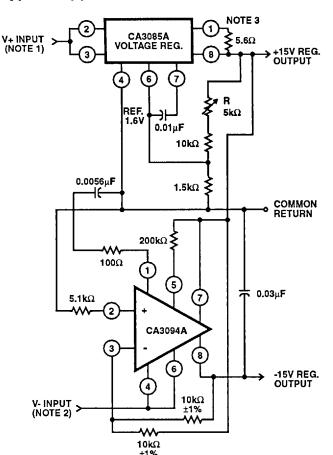


FIGURE 34. TEMPERATURE CONTROLLER

## Typical Applications (Continued)



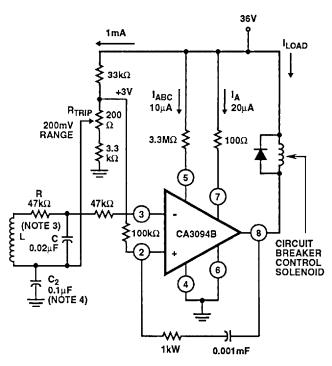
#### NOTES:

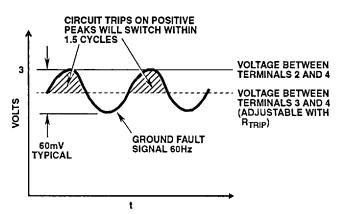
- 1. V+ Input Range = 19V to 30V for 15V output.
- 2. V- Input Range = -16V to -30V for -15V output.
- 3. Max  $I_{OUT} = \pm 100 \text{mA}$ .
- 4. Regulation:

Max Line = 
$$\frac{\Delta V_{OUT}}{[V_{OUT}(Initial)] \Delta V_{IN}} \times 100 = 0.075\%/V$$

Max. Load = 
$$\frac{\Delta V_{OUT}}{V_{OUT}(Initial)} \times 100 = 0.075\% V_{OUT}$$
(IL from 1mA to 50mA)

FIGURE 35. DUAL VOLTAGE TRACKING REGULATOR



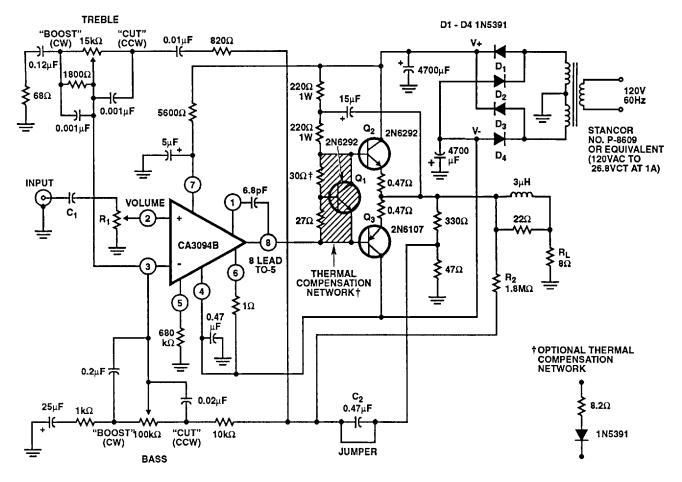


#### NOTES:

- Differential current sensor provides 60mV signal ~ 5mA of unbalance (Trip) current.
- 2. All Resistors are 1/2 Watt, ±10%.
- 3. RC selected for 3dB point at 200Hz.
- 4. C<sub>2</sub> = AC by-pass.
- 5. Offset adj. included in RTRIP.
- 6. Input impedance from 2 to  $3 = 800k\Omega$ .
- 7. With no input signal Terminal 8 (output) at 36V.

FIGURE 36. GROUND FAULT INTERRUPTER (GFI) AND WAVEFORMS PERTINENT TO GROUND FAULT DETECTOR

## Typical Applications (Continued)



#### TYPICAL PERFORMANCE DATA FOR 12W AUDIO AMPLIFIER CIRCUIT

Power Output (8 $\Omega$ load, Tone Control set at "Flat") Music (at 5% THD, regulated supply)15W Continuous (at 0.2% IMD, 60Hz and 2kHz	Voltage Gain
mixed in a 4.1 ratio, unregulated supply) See Figure 8 in AN604812W	Tone Control Range
Total Harmonic Distortion	
At 1W, unregulated supply	
At 1211, unregulated supply 0.57 /6	

FIGURE 37. 12W AUDIO AMPLIFIER CIRCUIT FEATURING TRUE COMPLEMENTARY SYMMETRY OUTPUT STAGE WITH CA3094 IN DRIVER STAGE